

Search Notes

Application/Control No.

10/701,258

Applicant(s)/Patent under
Reexamination

LANG ET AL.

Examiner

Jeffrey D. Lane

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
diffraction efficiency	4/6/2006	JL